Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,610	PARKER, IAN D.	
Examiner	Art Unit	
Thinh T. Nauvon	2010	

SEARCHED			
Class	Subclass	Date	Examiner
257	040	10/19/2005	TTN
257	759	10/19/2005	TTN
257	642	10/20/2005	TTN
257	643	10/20/2005	TTN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	ARCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
EAST	10/19/2005	TTN
EAST	10/20/2005	TTN
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